

# MTD3302

## Advance Information

### Power MOSFET 18 Amps, 30 Volts N-Channel DPAK

This Power MOSFET is capable of withstanding high energy in the avalanche and commutation modes and the drain-to-source diode has a very low reverse recovery time. These devices are designed for use in low voltage, high speed switching applications where power efficiency is important. Typical applications are dc-dc converters, and power management in portable and battery powered products such as computers, printers, cellular and cordless phones. They can also be used for low voltage motor controls in mass storage products such as disk drives and tape drives. The avalanche energy is specified to eliminate the guesswork in designs where inductive loads are switched and offer additional safety margin against unexpected voltage transients.

- Characterized Over a Wide Range of Power Ratings
- Ultralow  $R_{DS(on)}$  Provides Higher Efficiency and Extends Battery Life in Portable Applications
- Logic Level Gate Drive – Can Be Driven by Logic ICs
- Diode Is Characterized for Use In Bridge Circuits
- Diode Exhibits High Speed, With Soft Recovery
- $I_{DSS}$  Specified at Elevated Temperature
- Avalanche Energy Specified

#### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise specified)

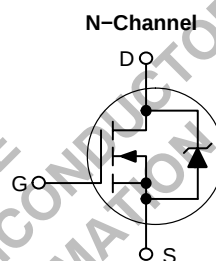
| Parameter                                                                                                                                                                                                                   | Symbol         | Value      | Unit             |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------|------------|------------------|
| Drain-to-Source Voltage                                                                                                                                                                                                     | $V_{DS}$       | 30         | Vdc              |
| Drain-to-Gate Voltage                                                                                                                                                                                                       | $V_{DGR}$      | 30         | Vdc              |
| Gate-to-Source Voltage                                                                                                                                                                                                      | $V_{GS}$       | $\pm 20$   | Vdc              |
| Gate-to-Source Operating Voltage                                                                                                                                                                                            | $V_{GS}$       | $\pm 16$   | Vdc              |
| Operating and Storage Temperature Range                                                                                                                                                                                     | $T_J, T_{stg}$ | -55 to 150 | $^\circ\text{C}$ |
| Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^\circ\text{C}$<br>( $V_{DD} = 25\text{ Vdc}$ , $V_{GS} = 10\text{ Vdc}$ ,<br>$L = 20\text{ mH}$ , $I_{L(pk)} = 10\text{ A}$ , $V_{DS} = 30\text{ Vdc}$ ) | $E_{AS}$       | 1000       | mJ               |



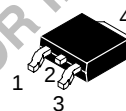
ON Semiconductor™

<http://onsemi.com>

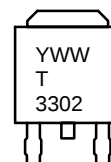
**18 AMPERES**  
**30 VOLTS**  
 $R_{DS(on)} = 10\text{ m}\Omega$



#### MARKING DIAGRAM

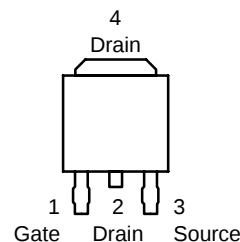


CASE 369A  
DPAK  
STYLE 2



Y = Year  
WW = Work Week  
T = MOSFET

#### PIN ASSIGNMENT



#### ORDERING INFORMATION

| Device    | Package | Shipping         |
|-----------|---------|------------------|
| MTD3302   | DPAK    | 75 Units/Rail    |
| MTD3302T4 | DPAK    | 2500 Tape & Reel |

This document contains information on a new product. Specifications and information herein are subject to change without notice.

# MTD3302

## POWER RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise specified)

| Parameter                                                                                                                                         |                                                              | Symbol          | Value | Unit                       |
|---------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------|-----------------|-------|----------------------------|
| Drain Current – Continuous @ $T_A = 25^\circ\text{C}$<br>– Continuous @ $T_A = 100^\circ\text{C}$<br>– Single Pulse ( $t_p \leq 10 \mu\text{s}$ ) | Mounted on heat sink<br>$T_{\text{case}} = 25^\circ\text{C}$ | $I_D$           | 30    | Adc                        |
|                                                                                                                                                   |                                                              | $I_D$           | 30    | Adc                        |
|                                                                                                                                                   |                                                              | $I_{DM}$        | 90    | Adc                        |
|                                                                                                                                                   |                                                              | $P_D$           | 96    | Watts                      |
| Total Power Dissipation @ $T_A = 25^\circ\text{C}$<br>Linear Derating Factor                                                                      | $V_{GS} = 10 \text{ Vdc}$                                    |                 | 769   | $\text{mW}/^\circ\text{C}$ |
| Thermal Resistance – Junction-to-Case                                                                                                             | Steady State                                                 | $R_{\theta JC}$ | 1.3   | $^\circ\text{C}/\text{W}$  |
| Continuous Source Current (Diode Conduction)                                                                                                      |                                                              | $I_S$           | 30    | Adc                        |

| Parameter                                                                                                                                         |                                               | Symbol          | Value | Unit                       |
|---------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------|-----------------|-------|----------------------------|
| Drain Current – Continuous @ $T_A = 25^\circ\text{C}$<br>– Continuous @ $T_A = 100^\circ\text{C}$<br>– Single Pulse ( $t_p \leq 10 \mu\text{s}$ ) | Mounted on 1 inch square<br>FR-4 or G10 board | $I_D$           | 18.3  | Adc                        |
|                                                                                                                                                   |                                               | $I_D$           | 11.2  | Adc                        |
|                                                                                                                                                   |                                               | $I_{DM}$        | 60    | Adc                        |
|                                                                                                                                                   |                                               | $P_D$           | 5.0   | Watts                      |
| Total Power Dissipation @ $T_A = 25^\circ\text{C}$<br>Linear Derating Factor                                                                      | $V_{GS} = 10 \text{ Vdc}$                     |                 | 40    | $\text{mW}/^\circ\text{C}$ |
| Thermal Resistance – Junction-to-Ambient                                                                                                          | $t \leq 10 \text{ seconds}$                   | $R_{\theta JA}$ | 25    | $^\circ\text{C}/\text{W}$  |
| Continuous Source Current (Diode Conduction)                                                                                                      |                                               | $I_S$           | 6.4   | Adc                        |

| Parameter                                                                                                                                         |                                               | Symbol          | Value | Unit                       |
|---------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------|-----------------|-------|----------------------------|
| Drain Current – Continuous @ $T_A = 25^\circ\text{C}$<br>– Continuous @ $T_A = 100^\circ\text{C}$<br>– Single Pulse ( $t_p \leq 10 \mu\text{s}$ ) | Mounted on 1 inch square<br>FR-4 or G10 board | $I_D$           | 11.2  | Adc                        |
|                                                                                                                                                   |                                               | $I_D$           | 8.6   | Adc                        |
|                                                                                                                                                   |                                               | $I_{DM}$        | 40    | Adc                        |
|                                                                                                                                                   |                                               | $P_D$           | 1.9   | Watts                      |
| Total Power Dissipation @ $T_A = 25^\circ\text{C}$<br>Linear Derating Factor                                                                      | $V_{GS} = 10 \text{ Vdc}$                     |                 | 15    | $\text{mW}/^\circ\text{C}$ |
| Thermal Resistance – Junction-to-Ambient                                                                                                          | Steady State                                  | $R_{\theta JA}$ | 67    | $^\circ\text{C}/\text{W}$  |
| Continuous Source Current (Diode Conduction)                                                                                                      |                                               | $I_S$           | 2.5   | Adc                        |

| Parameter                                                                                                                                         |                                                     | Symbol          | Value | Unit                       |
|---------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------|-----------------|-------|----------------------------|
| Drain Current – Continuous @ $T_A = 25^\circ\text{C}$<br>– Continuous @ $T_A = 100^\circ\text{C}$<br>– Single Pulse ( $t_p \leq 10 \mu\text{s}$ ) | Mounted on minimum recommended<br>FR-4 or G10 board | $I_D$           | 8.3   | Adc                        |
|                                                                                                                                                   |                                                     | $I_D$           | 5.2   | Adc                        |
|                                                                                                                                                   |                                                     | $I_{DM}$        | 30    | Adc                        |
|                                                                                                                                                   |                                                     | $P_D$           | 1.0   | Watts                      |
| Total Power Dissipation @ $T_A = 25^\circ\text{C}$<br>Linear Derating Factor                                                                      | $V_{GS} = 10 \text{ Vdc}$                           |                 | 8.3   | $\text{mW}/^\circ\text{C}$ |
| Thermal Resistance – Junction-to-Ambient                                                                                                          | Steady State                                        | $R_{\theta JA}$ | 120   | $^\circ\text{C}/\text{W}$  |
| Continuous Source Current (Diode Conduction)                                                                                                      |                                                     | $I_S$           | 1.4   | Adc                        |

# MTD3302

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

### OFF CHARACTERISTICS

|                                                                                                                                                                       |                      |         |              |           |              |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------|---------|--------------|-----------|--------------|
| Drain-to-Source Breakdown Voltage<br>(V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 250 μAdc)<br>Temperature Coefficient (Positive)                                       | V <sub>(BR)DSS</sub> | 30<br>– | 33<br>23     | –<br>–    | Vdc<br>mV/°C |
| Zero Gate Voltage Drain Current<br>(V <sub>DS</sub> = 30 Vdc, V <sub>GS</sub> = 0 Vdc)<br>(V <sub>DS</sub> = 30 Vdc, V <sub>GS</sub> = 0 Vdc, T <sub>J</sub> = 125°C) | I <sub>DSS</sub>     | –<br>–  | 0.005<br>0.5 | 1.0<br>10 | μAdc         |
| Gate-Body Leakage Current (V <sub>GS</sub> = ± 20 Vdc, V <sub>DS</sub> = 0 Vdc)                                                                                       | I <sub>GSS</sub>     | –       | 2            | ±100      | nAdc         |

### ON CHARACTERISTICS (Note 1.)

|                                                                                                                                                      |                     |          |            |          |              |
|------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|----------|------------|----------|--------------|
| Gate Threshold Voltage<br>(V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μAdc)<br>Threshold Temperature Coefficient (Negative)            | V <sub>GS(th)</sub> | 1.0<br>– | 1.9<br>4.6 | –<br>–   | Vdc<br>mV/°C |
| Static Drain-to-Source On-Resistance<br>(V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 10 Adc)<br>(V <sub>GS</sub> = 4.5 Vdc, I <sub>D</sub> = 5.0 Adc) | R <sub>DS(on)</sub> | –<br>–   | 8.9<br>13  | 10<br>16 | mΩ           |
| Forward Transconductance (V <sub>DS</sub> = 15 Vdc, I <sub>D</sub> = 10 Adc)                                                                         | g <sub>FS</sub>     | 12       | 19         | –        | Mhos         |

### DYNAMIC CHARACTERISTICS

|                      |                                                                     |                  |   |      |   |    |
|----------------------|---------------------------------------------------------------------|------------------|---|------|---|----|
| Input Capacitance    | (V <sub>DS</sub> = 24 Vdc, V <sub>GS</sub> = 0 Vdc,<br>f = 1.0 MHz) | C <sub>iss</sub> | – | 1760 | – | pF |
| Output Capacitance   |                                                                     | C <sub>oss</sub> | – | 610  | – |    |
| Transfer Capacitance |                                                                     | C <sub>rss</sub> | – | 185  | – |    |

### SWITCHING CHARACTERISTICS (Note 2.)

|                     |                                                                                                               |                     |   |      |     |    |
|---------------------|---------------------------------------------------------------------------------------------------------------|---------------------|---|------|-----|----|
| Turn-On Delay Time  | (V <sub>DD</sub> = 25 Vdc, I <sub>D</sub> = 1.0 Adc,<br>V <sub>GS</sub> = 10 Vdc,<br>R <sub>G</sub> = 6.0 Ω)  | t <sub>d(on)</sub>  | – | 10   | 20  | ns |
| Rise Time           |                                                                                                               | t <sub>r</sub>      | – | 30   | 60  |    |
| Turn-Off Delay Time |                                                                                                               | t <sub>d(off)</sub> | – | 65   | 130 |    |
| Fall Time           |                                                                                                               | t <sub>f</sub>      | – | 58   | 110 |    |
| Turn-On Delay Time  | (V <sub>DD</sub> = 25 Vdc, I <sub>D</sub> = 1.0 Adc,<br>V <sub>GS</sub> = 4.5 Vdc,<br>R <sub>G</sub> = 6.0 Ω) | t <sub>d(on)</sub>  | – | 20   | 40  | ns |
| Rise Time           |                                                                                                               | t <sub>r</sub>      | – | 86   | 170 |    |
| Turn-Off Delay Time |                                                                                                               | t <sub>d(off)</sub> | – | 44   | 80  |    |
| Fall Time           |                                                                                                               | t <sub>f</sub>      | – | 48   | 90  |    |
| Gate Charge         | (V <sub>DS</sub> = 15 Vdc, I <sub>D</sub> = 2.0 Adc,<br>V <sub>GS</sub> = 10 Vdc)                             | Q <sub>T</sub>      | – | 47   | 60  | nC |
|                     |                                                                                                               | Q <sub>1</sub>      | – | 4.8  | –   |    |
|                     |                                                                                                               | Q <sub>2</sub>      | – | 16.7 | –   |    |
|                     |                                                                                                               | Q <sub>3</sub>      | – | 11.2 | –   |    |

### SOURCE-DRAIN DIODE CHARACTERISTICS

|                                |                                                                                                                                    |                 |        |              |          |     |
|--------------------------------|------------------------------------------------------------------------------------------------------------------------------------|-----------------|--------|--------------|----------|-----|
| Forward On-Voltage (Note 1.)   | (I <sub>S</sub> = 2.3 Adc, V <sub>GS</sub> = 0 Vdc)<br>(I <sub>S</sub> = 2.3 Adc, V <sub>GS</sub> = 0 Vdc, T <sub>J</sub> = 125°C) | V <sub>SD</sub> | –<br>– | 0.87<br>0.72 | 1.1<br>– | Vdc |
| Reverse Recovery Time          | (I <sub>S</sub> = 2.3 Adc, V <sub>GS</sub> = 0 Vdc,<br>dI <sub>S</sub> /dt = 100 A/μs)                                             | t <sub>rr</sub> | –      | 41           | –        | ns  |
|                                |                                                                                                                                    | t <sub>a</sub>  | –      | 21           | –        |     |
|                                |                                                                                                                                    | t <sub>b</sub>  | –      | 20           | –        |     |
| Reverse Recovery Stored Charge |                                                                                                                                    | Q <sub>RR</sub> | –      | 0.047        | –        | μC  |

1. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
2. Switching characteristics are independent of operating junction temperatures.

TYPICAL ELECTRICAL CHARACTERISTICS

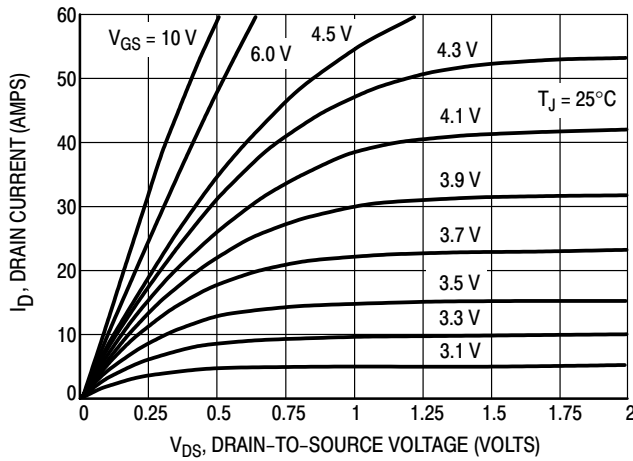


Figure 1. On-Region Characteristics

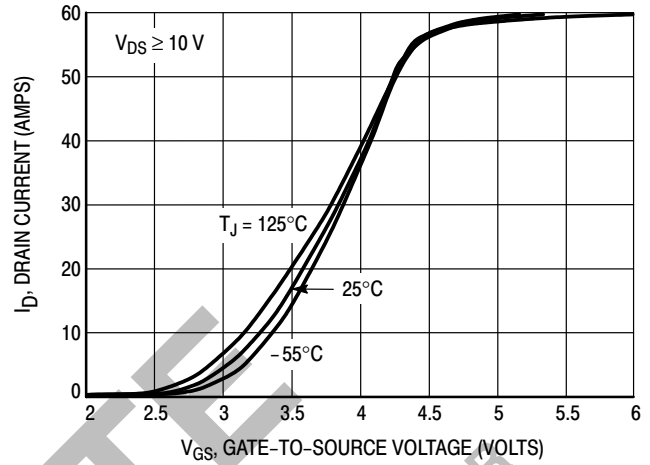


Figure 2. Transfer Characteristics

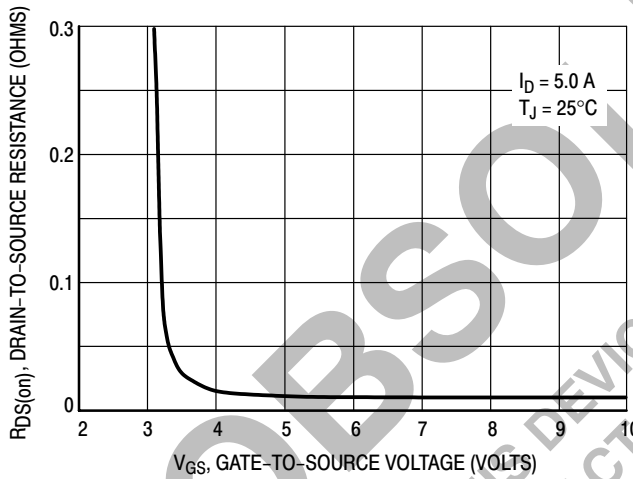


Figure 3. On-Resistance versus Gate-to-Source Voltage

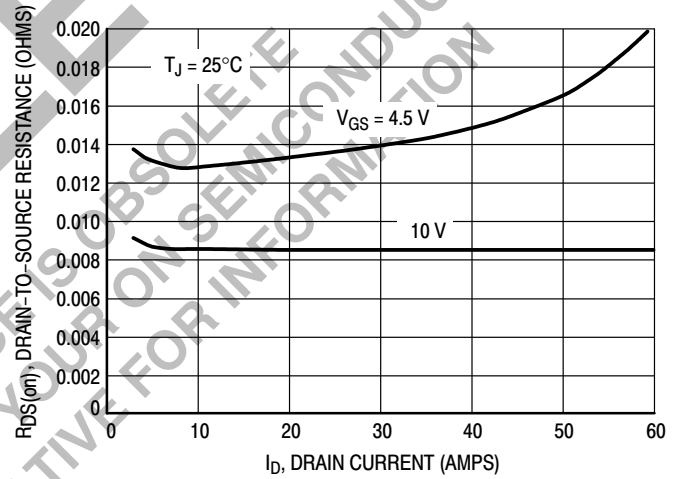


Figure 4. On-Resistance versus Drain Current and Gate Voltage

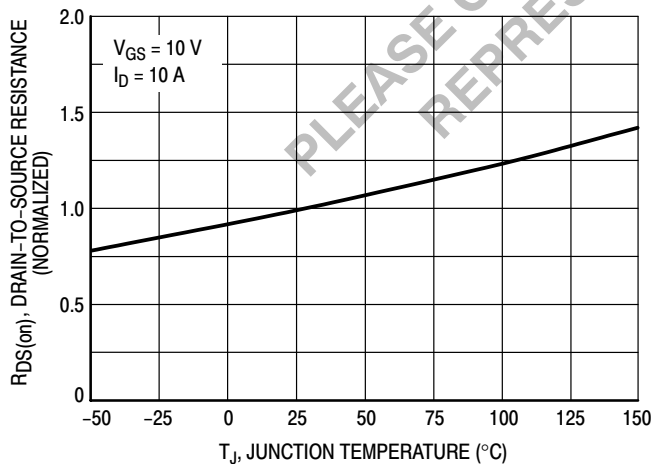


Figure 5. On-Resistance Variation with Temperature

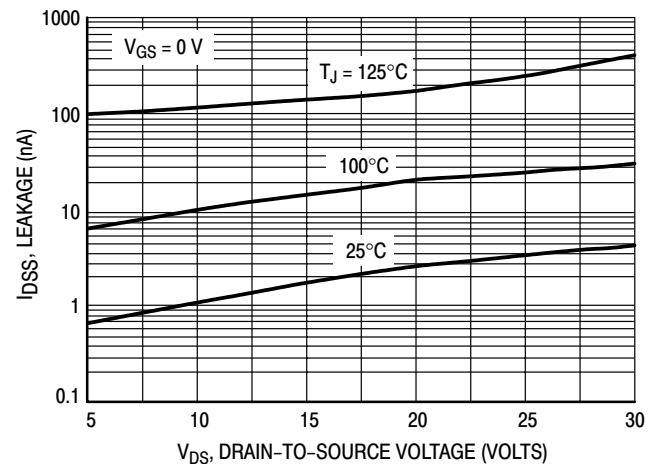


Figure 6. Drain-to-Source Leakage Current versus Voltage

## POWER MOSFET SWITCHING

Switching behavior is most easily modeled and predicted by recognizing that the power MOSFET is charge controlled. The lengths of various switching intervals ( $\Delta t$ ) are determined by how fast the FET input capacitance can be charged by current from the generator.

The published capacitance data is difficult to use for calculating rise and fall because drain-gate capacitance varies greatly with applied voltage. Accordingly, gate charge data is used. In most cases, a satisfactory estimate of average input current ( $I_{G(AV)}$ ) can be made from a rudimentary analysis of the drive circuit so that

$$t = Q/I_{G(AV)}$$

During the rise and fall time interval when switching a resistive load,  $V_{GS}$  remains virtually constant at a level known as the plateau voltage,  $V_{GSP}$ . Therefore, rise and fall times may be approximated by the following:

$$t_r = Q_2 \times R_G / (V_{GG} - V_{GSP})$$

$$t_f = Q_2 \times R_G / V_{GSP}$$

where

$V_{GG}$  = the gate drive voltage, which varies from zero to  $V_{GG}$

$R_G$  = the gate drive resistance

and  $Q_2$  and  $V_{GSP}$  are read from the gate charge curve.

During the turn-on and turn-off delay times, gate current is not constant. The simplest calculation uses appropriate values from the capacitance curves in a standard equation for voltage change in an RC network. The equations are:

$$t_{d(on)} = R_G C_{iss} \ln [V_{GG}/(V_{GG} - V_{GSP})]$$

$$t_{d(off)} = R_G C_{iss} \ln (V_{GG}/V_{GSP})$$

The capacitance ( $C_{iss}$ ) is read from the capacitance curve at a voltage corresponding to the off-state condition when calculating  $t_{d(on)}$  and is read at a voltage corresponding to the on-state when calculating  $t_{d(off)}$ .

At high switching speeds, parasitic circuit elements complicate the analysis. The inductance of the MOSFET source lead, inside the package and in the circuit wiring which is common to both the drain and gate current paths, produces a voltage at the source which reduces the gate drive current. The voltage is determined by  $L di/dt$ , but since  $di/dt$  is a function of drain current, the mathematical solution is complex. The MOSFET output capacitance also complicates the mathematics. And finally, MOSFETs have finite internal gate resistance which effectively adds to the resistance of the driving source, but the internal resistance is difficult to measure and, consequently, is not specified.

The resistive switching time variation versus gate resistance (Figure 9) shows how typical switching performance is affected by the parasitic circuit elements. If the parasitics were not present, the slope of the curves would maintain a value of unity regardless of the switching speed. The circuit used to obtain the data is constructed to minimize common inductance in the drain and gate circuit loops and is believed readily achievable with board mounted components. Most power electronic loads are inductive; the data in the figure is taken with a resistive load, which approximates an optimally snubbed inductive load. Power MOSFETs may be safely operated into an inductive load; however, snubbing reduces switching losses.

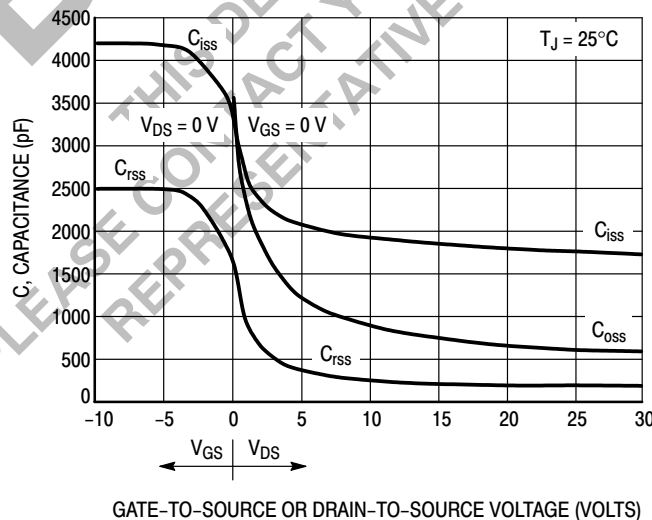


Figure 7. Capacitance Variation

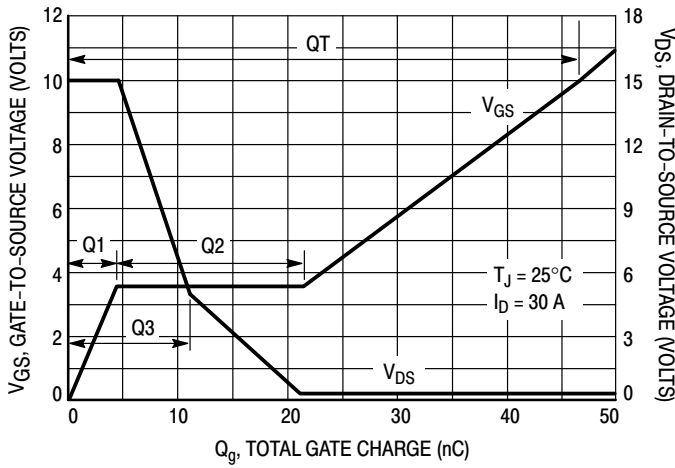


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

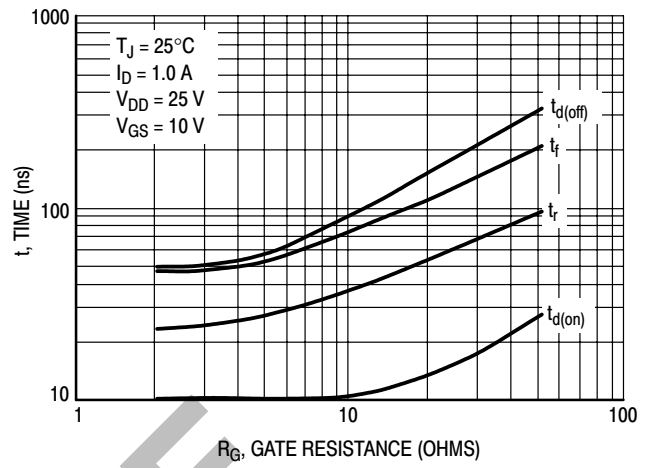


Figure 9. Resistive Switching Time Variation versus Gate Resistance

### DRAIN-TO-SOURCE DIODE CHARACTERISTICS

The switching characteristics of a MOSFET body diode are very important in systems using it as a freewheeling or commutating diode. Of particular interest are the reverse recovery characteristics which play a major role in determining switching losses, radiated noise, EMI and RFI.

System switching losses are largely due to the nature of the body diode itself. The body diode is a minority carrier device, therefore it has a finite reverse recovery time,  $t_{rr}$ , due to the storage of minority carrier charge,  $Q_{RR}$ , as shown in the typical reverse recovery wave form of Figure 11. It is this stored charge that, when cleared from the diode, passes through a potential and defines an energy loss. Obviously, repeatedly forcing the diode through reverse recovery further increases switching losses. Therefore, one would like a diode with short  $t_{rr}$  and low  $Q_{RR}$  specifications to minimize these losses.

The abruptness of diode reverse recovery effects the amount of radiated noise, voltage spikes, and current ringing. The mechanisms at work are finite irremovable circuit parasitic inductances and capacitances acted upon by

high  $di/dt$ s. The diode's negative  $di/dt$  during  $t_a$  is directly controlled by the device clearing the stored charge. However, the positive  $di/dt$  during  $t_b$  is an uncontrollable diode characteristic and is usually the culprit that induces current ringing. Therefore, when comparing diodes, the ratio of  $t_b/t_a$  serves as a good indicator of recovery abruptness and thus gives a comparative estimate of probable noise generated. A ratio of 1 is considered ideal and values less than 0.5 are considered snappy.

Compared to ON Semiconductor standard cell density low voltage MOSFETs, high cell density MOSFET diodes are faster (shorter  $t_{rr}$ ), have less stored charge and a softer reverse recovery characteristic. The softness advantage of the high cell density diode means they can be forced through reverse recovery at a higher  $di/dt$  than a standard cell MOSFET diode without increasing the current ringing or the noise generated. In addition, power dissipation incurred from switching the diode will be less due to the shorter recovery time and lower switching losses.

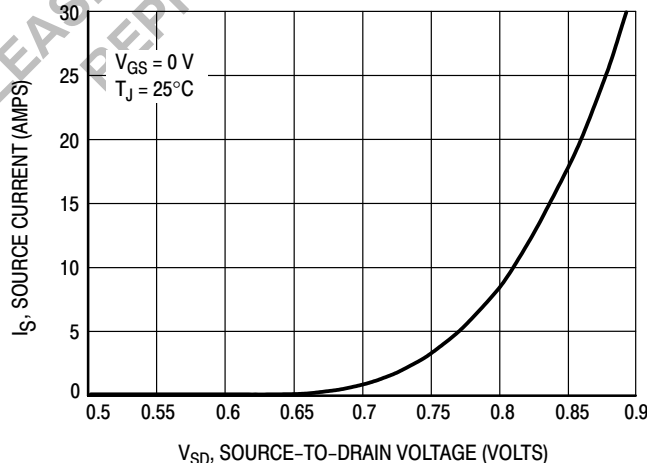


Figure 10. Diode Forward Voltage versus Current

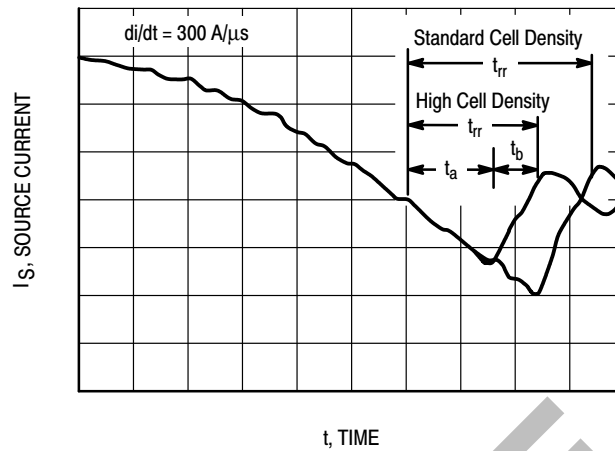


Figure 11. Reverse Recovery Time ( $t_{rr}$ )

### SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature ( $T_C$ ) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance – General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current ( $I_{DM}$ ) nor rated voltage ( $V_{DSS}$ ) is exceeded, and that the transition time ( $t_r$ ,  $t_f$ ) does not exceed 10  $\mu\text{s}$ . In addition the

total power averaged over a complete switching cycle must not exceed  $(T_{J(MAX)} - T_C)/(R_{\theta JC})$ .

A power MOSFET designated E-FET can be safely used in switching circuits with unclamped inductive loads. For reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and must be adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non-linearly with an increase of peak current in avalanche and peak junction temperature.

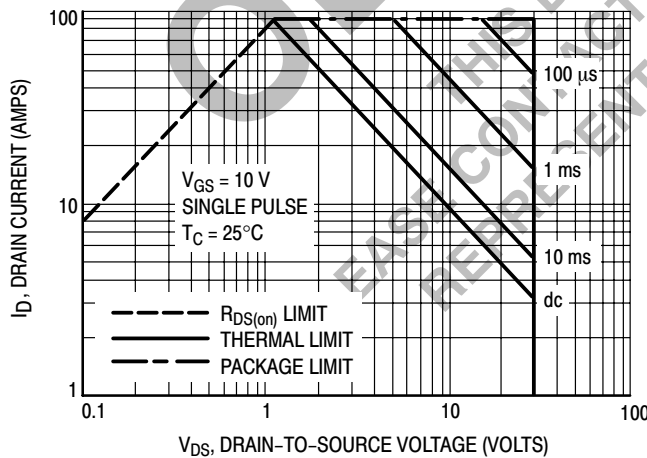


Figure 12. Maximum Rated Forward Biased Safe Operating Area

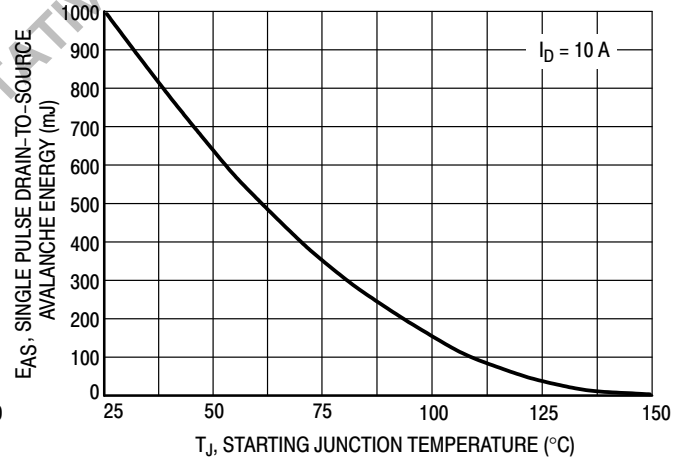


Figure 13. Maximum Avalanche Energy versus Starting Junction Temperature

TYPICAL ELECTRICAL CHARACTERISTICS

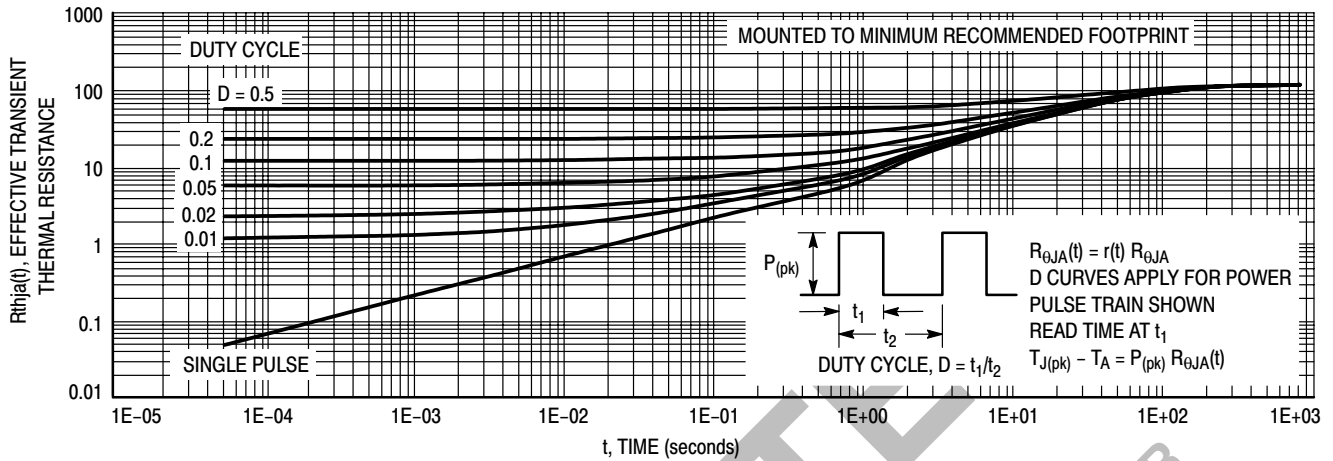


Figure 14. Thermal Response – Various Duty Cycles

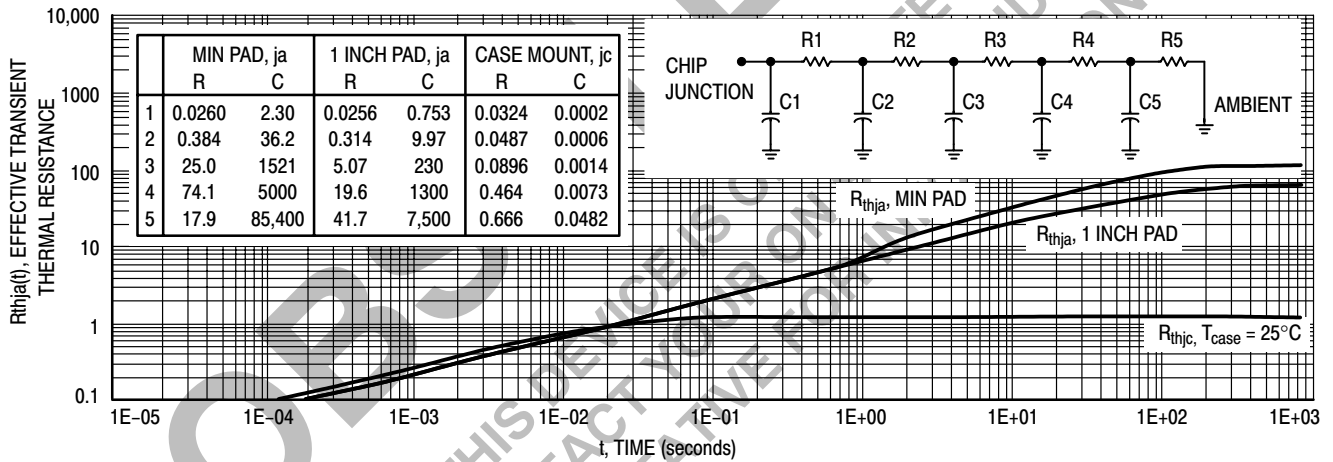


Figure 15. Thermal Response – Various Mounting/Measurement Conditions

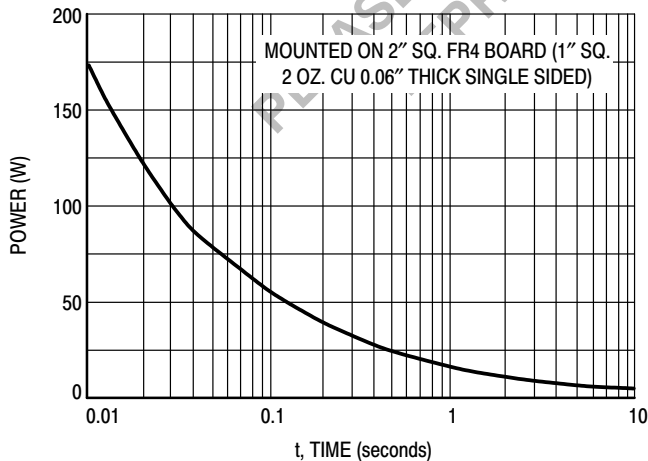


Figure 16. Single Pulse Power

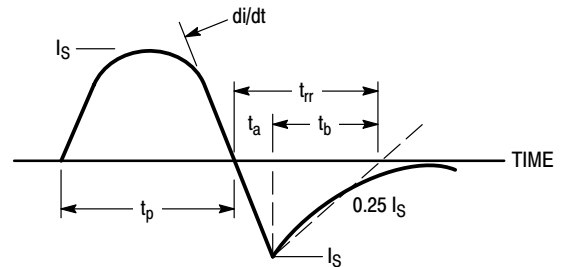


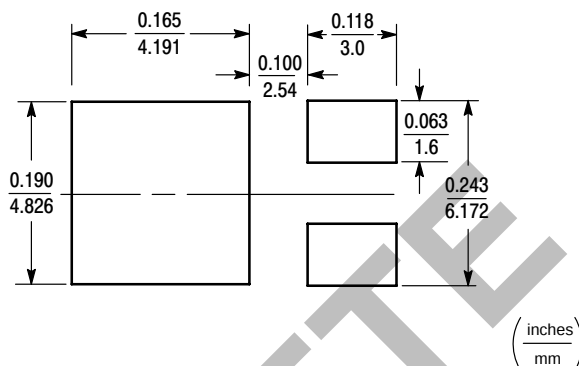
Figure 17. Diode Reverse Recovery Waveform

## INFORMATION FOR USING THE DPAK SURFACE MOUNT PACKAGE

### RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to ensure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



### POWER DISSIPATION FOR A SURFACE MOUNT DEVICE

The power dissipation for a surface mount device is a function of the drain pad size. These can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by  $T_{J(max)}$ , the maximum rated junction temperature of the die,  $R_{\theta JA}$ , the thermal resistance from the device junction to ambient, and the operating temperature,  $T_A$ . Using the values provided on the data sheet,  $P_D$  can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature  $T_A$  of 25°C, one can calculate the power dissipation of the device. For a DPAK device,  $P_D$  is calculated as follows.

$$P_D = \frac{150^\circ\text{C} - 25^\circ\text{C}}{71.4^\circ\text{C/W}} = 1.75 \text{ Watts}$$

The 71.4°C/W for the DPAK package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 1.75 Watts. Note that these values may vary depending on the device type. Consult the maximum ratings table on the data sheet to find the actual  $P_D$  and  $R_{\theta JA}$  values for a particular device. There are other alternatives to achieving higher power dissipation from the surface mount packages. One is to increase the area of the drain pad. By increasing the area of the drain pad, the power dissipation can be increased. Although one can almost double the power dissipation with this method, one will be giving up area on the printed circuit board which can defeat the purpose of using surface mount technology. For example, a graph of  $R_{\theta JA}$  versus drain pad area is shown in Figure 18.

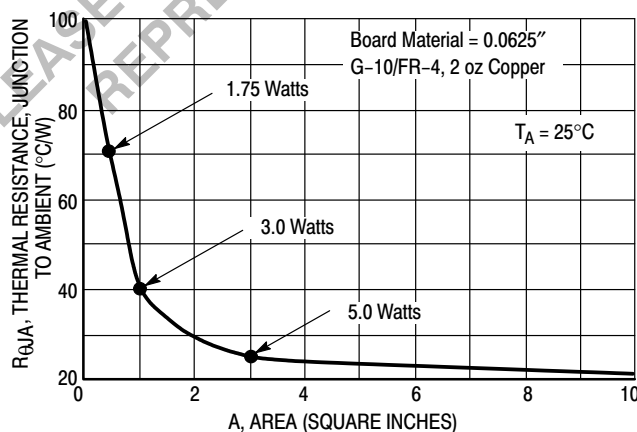


Figure 18. Thermal Resistance versus Drain Pad Area for the DPAK Package (Typical)

Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core

board, the power dissipation can be doubled using the same footprint.

### SOLDER STENCIL GUIDELINES

Prior to placing surface mount components onto a printed circuit board, solder paste must be applied to the pads. Solder stencils are used to screen the optimum amount. These stencils are typically 0.008 inches thick and may be made of brass or stainless steel. For packages such as the SC-59, SC-70/SOT-323, SOD-123, SOT-23, SOT-143, SOT-223, SO-8, SO-14, SO-16, and SMB/SMC diode packages, the stencil opening should be the same as the pad size or a 1:1 registration. This is not the case with the DPAK and D<sup>2</sup>PAK packages. If one uses a 1:1 opening to screen solder onto the drain pad, misalignment and/or “tombstoning” may occur due to an excess of solder. For these two packages, the opening in the stencil for the paste should be approximately 50% of the tab area. The opening for the leads is still a 1:1 registration. Figure 16 shows a typical stencil for the DPAK and D<sup>2</sup>PAK packages. The

pattern of the opening in the stencil for the drain pad is not critical as long as it allows approximately 50% of the pad to be covered with paste.

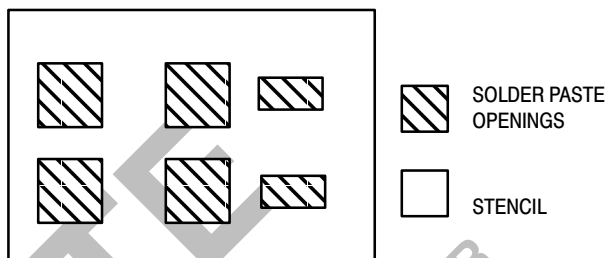


Figure 19. Typical Stencil for DPAK and D<sup>2</sup>PAK Packages

### SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.\*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.

- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes. Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

\* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

\* Due to shadowing and the inability to set the wave height to incorporate other surface mount components, the D<sup>2</sup>PAK is not recommended for wave soldering.

### TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones and a figure for belt speed. Taken together, these control settings make up a heating “profile” for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 20 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems, but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows

temperature versus time. The line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between 177–189°C. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.

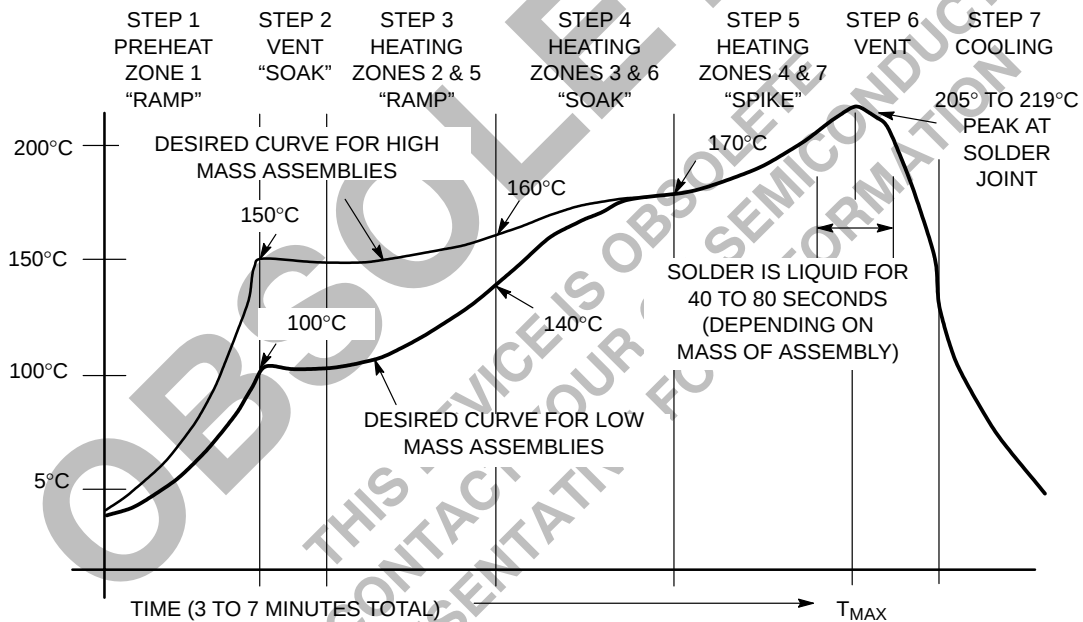
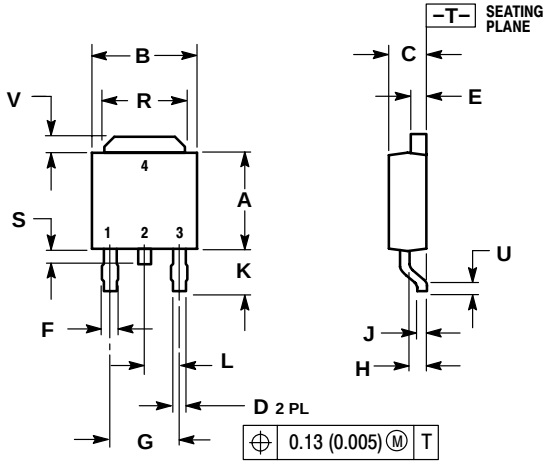


Figure 20. Typical Solder Heating Profile

# MTD3302

## PACKAGE DIMENSIONS

DPAK  
CASE 369A-13  
ISSUE AA



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

| DIM | INCHES    |       | MILLIMETERS |      |
|-----|-----------|-------|-------------|------|
|     | MIN       | MAX   | MIN         | MAX  |
| A   | 0.235     | 0.250 | 5.97        | 6.35 |
| B   | 0.250     | 0.265 | 6.35        | 6.73 |
| C   | 0.086     | 0.094 | 2.19        | 2.38 |
| D   | 0.027     | 0.035 | 0.69        | 0.88 |
| E   | 0.033     | 0.040 | 0.84        | 1.01 |
| F   | 0.037     | 0.047 | 0.94        | 1.19 |
| G   | 0.180 BSC |       | 4.58 BSC    |      |
| H   | 0.034     | 0.040 | 0.87        | 1.01 |
| J   | 0.018     | 0.023 | 0.46        | 0.58 |
| K   | 0.102     | 0.114 | 2.60        | 2.89 |
| L   | 0.090 BSC |       | 2.29 BSC    |      |
| R   | 0.175     | 0.215 | 4.45        | 5.46 |
| S   | 0.020     | 0.050 | 0.51        | 1.27 |
| U   | 0.020     | ---   | 0.51        | ---  |
| V   | 0.030     | 0.050 | 0.77        | 1.27 |
| Z   | 0.138     | ---   | 3.51        | ---  |

STYLE 2:  
PIN 1. GATE  
2. DRAIN  
3. SOURCE  
4. DRAIN

Thermal Clad is a registered trademark of the Bergquist Company.

ON Semiconductor and  are trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer.

## PUBLICATION ORDERING INFORMATION

### NORTH AMERICA Literature Fulfillment:

Literature Distribution Center for ON Semiconductor  
P.O. Box 5163, Denver, Colorado 80217 USA  
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada  
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada  
Email: [ONlit@hibbertco.com](mailto:ONlit@hibbertco.com)  
Fax Response Line: 303-675-2167 or 800-344-3810 Toll Free USA/Canada

### N. American Technical Support: 800-282-9855 Toll Free USA/Canada

### EUROPE: LDC for ON Semiconductor - European Support

German Phone: (+1) 303-308-7140 (Mon-Fri 2:30pm to 7:00pm CET)  
Email: [ONlit-german@hibbertco.com](mailto:ONlit-german@hibbertco.com)  
French Phone: (+1) 303-308-7141 (Mon-Fri 2:00pm to 7:00pm CET)  
Email: [ONlit-french@hibbertco.com](mailto:ONlit-french@hibbertco.com)  
English Phone: (+1) 303-308-7142 (Mon-Fri 12:00pm to 5:00pm GMT)  
Email: [ONlit@hibbertco.com](mailto:ONlit@hibbertco.com)

### EUROPEAN TOLL-FREE ACCESS\*: 00-800-4422-3781

\*Available from Germany, France, Italy, UK, Ireland

### CENTRAL/SOUTH AMERICA:

Spanish Phone: 303-308-7143 (Mon-Fri 8:00am to 5:00pm MST)  
Email: [ONlit-spanish@hibbertco.com](mailto:ONlit-spanish@hibbertco.com)  
Toll-Free from Mexico: Dial 01-800-288-2872 for Access -  
then Dial 866-297-9322

### ASIA/PACIFIC: LDC for ON Semiconductor - Asia Support

Phone: 303-675-2121 (Tue-Fri 9:00am to 1:00pm, Hong Kong Time)  
Toll Free from Hong Kong & Singapore:  
001-800-4422-3781  
Email: [ONlit-asia@hibbertco.com](mailto:ONlit-asia@hibbertco.com)

### JAPAN: ON Semiconductor, Japan Customer Focus Center

4-32-1 Nishi-Gotanda, Shinagawa-ku, Tokyo, Japan 141-0031  
Phone: 81-3-5740-2700  
Email: [r14525@onsemi.com](mailto:r14525@onsemi.com)

### ON Semiconductor Website: <http://onsemi.com>

For additional information, please contact your local Sales Representative.